

N-Ch MOSFET

General Description

The WSF3040 is the highest performance trench N-ch MOSFETs with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSF3040 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Absolute Maximum Ratings

Product Summery

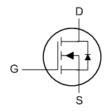
BVDSS	RDSON	ID
30V	10mΩ	43A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

TO-252 Pin Configuration





Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	43	A
I _D @T _C =100℃	Continuous Drain Current, V _{GS} @ 10V ¹	30	A
I _D @T _A =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	11	A
I _D @T _A =70℃	Continuous Drain Current, V _{GS} @ 10V ¹	9	A
I _{DM}	Pulsed Drain Current ²	112	A
EAS	Single Pulse Avalanche Energy ³	53	mJ
I _{AS}	Avalanche Current	22	A
P₀@T₀=25℃	Total Power Dissipation ⁴	37.5	W
P _D @T _A =25℃	Total Power Dissipation ⁴	2	W
T _{STG}	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C

Thermal Data

Symbol	Parameter	Typ. Max.		Unit	
R _{θJA}	Thermal Resistance Junction-Ambient ¹		62	°C/W	
R _{θJC}	Thermal Resistance Junction-Case ¹		4	°C/W	



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Electrical Characteristics (T_J=25⁻¹C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
$\triangle BV_{DSS} / \triangle T_J$	BVDSS Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$, I_D=1mA		0.0193		V/℃
В	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =30A		10	12	
R _{DS(ON)}		V _{GS} =4.5V , I _D =15A		15	18	mΩ
V _{GS(th)}	Gate Threshold Voltage		1.2	1.5	2.5	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, I _D =250uA		-3.97		mV/℃
1	Drain Source Lookage Current	V _{DS} =24V , V _{GS} =0V , T _J =25℃			1	— uA
I _{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}\text{=}24V$, $V_{\text{GS}}\text{=}0V$, $T_{\text{J}}\text{=}55^\circ\!\!\mathrm{C}$			5	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		34		S
R _g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.8	3.6	Ω
Qg	Total Gate Charge (4.5V)			9.8	13.7	
Q _{gs}	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =15A		4.2	5.88	nC
Q _{gd}	Gate-Drain Charge			3.6	5.0	
T _{d(on)}	Turn-On Delay Time			5	8.0	
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V , R _G =3.3Ω I _D =15A		8	14	
T _{d(off)}	Turn-Off Delay Time			31	62	ns
T _f	Fall Time			4	8	
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		940	1316	
C _{oss}	Output Capacitance			131	183	pF
C _{rss}	Reverse Transfer Capacitance			109	153	1

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy⁵	V _{DD} =25V , L=0.1mH , I _{AS} =15A	24.6			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}				15	A
I _{SM}	Pulsed Source Current ^{2,6}	$V_G=V_D=0V$, Force Current			112	A
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1	V
t _{rr}	Reverse Recovery Time			8.5		nS
Qrr	Reverse Recovery Charge	l͡⊧=30A , dl/dt=100A/μs , Tյ=25℃		2.2		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3.The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=15A

4.The power dissipation is limited by $175\,^\circ\!\!\mathbb{C}$ junction temperature

5.The Min. value is 100% EAS tested guarantee.

6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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Typical Characteristics

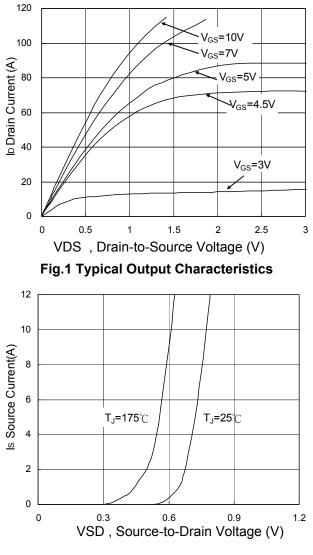
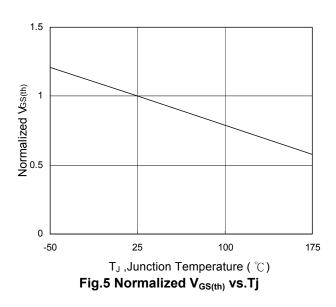


Fig.3 Forward Characteristics of Reverse



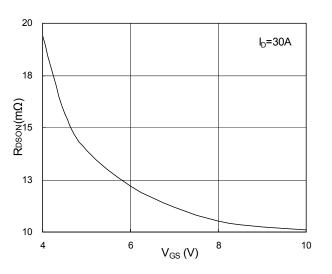


Fig.2 On-Resistance vs. G-S Voltage

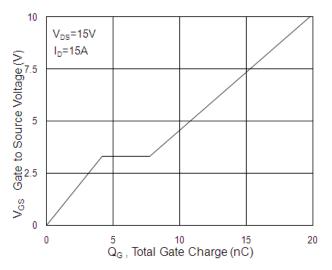
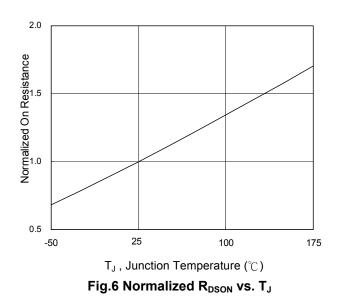


Fig.4 Gate-Charge Characteristics





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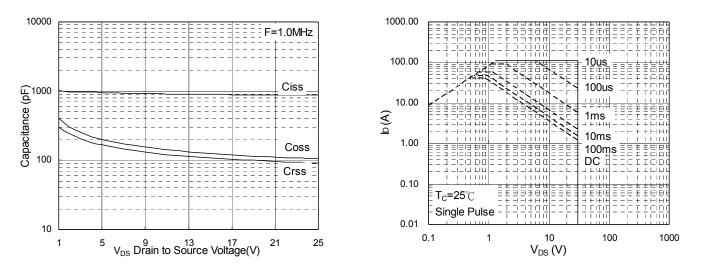


Fig.7 Capacitance

Fig.8 Safe Operating Area

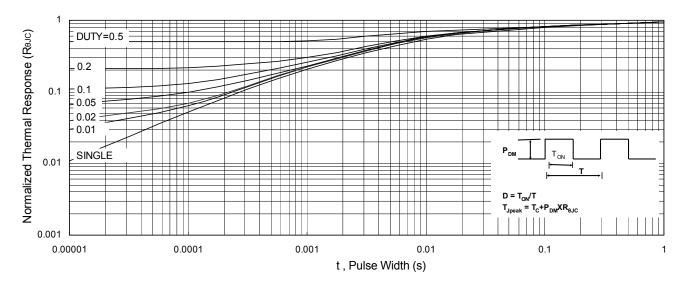
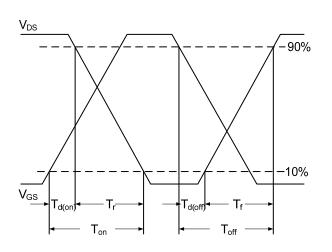
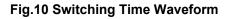


Fig.9 Normalized Maximum Transient Thermal Impedance





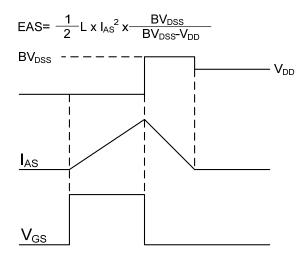


Fig.11 Unclamped Inductive Switching Waveform



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